

Notice of References Cited	Application/Control No. 10/672,013	Applicant(s)/Patent Under Reexamination AHN ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,882,416	03-1999	Van Buskirk et al.	118/726
*	B	US-6,277,201	08-2001	Nishikawa, Tomohisa	118/726
*	C	US-6,461,436	10-2002	Campbell et al.	118/715
*	D	US-6,473,563	10-2002	Takamatsu et al.	392/388
*	E	US-6,630,201	10-2003	Chiang et al.	427/255.28
*	F	US-6,789,789	09-2004	Randive et al.	261/133
*	G	US-6,969,539	11-2005	Gordon et al.	427/255.29
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001-011634	01-2001	Japan	Ono	
	O	WO 01/40541	06-2001	PCT	Aro	
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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